# 3.3V 1:2 Fanout Differential LVPECL/LVDS to LVTTL Translator

#### Description

The MC100EPT26 is a 1:2 Fanout Differential LVPECL/LVDS to LVTTL translator. Because LVPECL (Positive ECL) or LVDS levels are used only +3.3 V and ground are required. The small outline 8-lead package and the 1:2 fanout design of the EPT26 makes it ideal for applications which require the low skew duplication of a signal in a tightly packed PC board.

The  $V_{BB}$  output allows the EPT26 to be used in a single–ended input mode. In this mode the  $V_{BB}$  output is tied to the  $\overline{D0}$  input for a non–inverting buffer or the D0 input for an inverting buffer. If used, the  $V_{BB}$  pin should be bypassed to ground with > 0.01  $\mu F$  capacitor. For a single–ended direct connection, use an external voltage reference source such as a resistor divider. Do not use  $V_{BB}$  for a single–ended direct connection or port to another device.

#### **Features**

- 1.4 ns Typical Propagation Delay
- Maximum Frequency > 275 MHz Typical
- The 100 Series Contains Temperature Compensation
- Operating Range:  $V_{CC} = 3.0 \text{ V}$  to 3.6 V with GND = 0 V
- 24 mA TTL outputs
- Q Outputs Will Default LOW with Inputs Open or at V<sub>EE</sub>
- V<sub>BB</sub> Output
- Pb-Free Packages are Available



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#### MARKING DIAGRAMS\*



SO-8 D SUFFIX CASE 751





TSSOP-8 DT SUFFIX CASE 948R





DFN8 MN SUFFIX CASE 506AA



A = Assembly Location

L = Wafer Lot

Y = Year

W = Work Week

M = Date Code

■ = Pb-Free Package

(Note: Microdot may be in either location)

\*For additional marking information, refer to Application Note AND8002/D.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

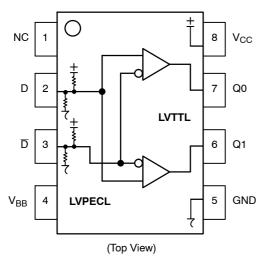


Figure 1. 8-Lead Pinout and Logic Diagram

#### **Table 1. PIN DESCRIPTION**

Pin	Function
Q0, Q1	LVTTL Outputs
D0**, D1**	Differential LVPECL Inputs Pair
V <sub>CC</sub>	Positive Supply
V <sub>BB</sub>	Output Reference Voltage
GND	Ground
NC	No Connect
EP	(DFN8 only) Thermal exposed pad must be connected to a sufficient thermal conduit. Electrically connect to the most negative supply (GND) or leave unconnected, floating open.

<sup>\*\*</sup> Pins will default to  $V_{\mbox{\footnotesize CC}}/2$  when left open.

#### Table 2. ATTRIBUTES

Charact	Value		
Internal Input Pulldown Resistor	50 kΩ		
Internal Input Pullup Resistor		50	kΩ
ESD Protection	> 1.5 kV > 100 V > 2 kV		
Moisture Sensitivity, Indefinite Ti	Pb Pkg	Pb-Free Pkg	
	Level 1 Level 1 Level 1	Level 1 Level 3 Level 1	
Flammability Rating	UL 94 V-0	@ 0.125 in	
Transistor Count	117 D	evices	
Meets or exceeds JEDEC Spec	EIA/JESD78 IC Latchup Test		

<sup>1.</sup> For additional information, see Application Note AND8003/D.

**Table 3. MAXIMUM RATINGS** 

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC</sub>	Positive Power Supply	GND = 0 V		3.8	V
V <sub>IN</sub>	Input Voltage	GND = 0 V	$V_I \leq V_{CC}$	0 to 3.8	V
I <sub>BB</sub>	V <sub>BB</sub> Sink/Source			± 0.5	mA
T <sub>A</sub>	Operating Temperature Range			-40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	SOIC-8 SOIC-8	190 130	°C/W °C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	Standard Board	SOIC-8	41 to 44	°C/W
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	TSSOP-8 TSSOP-8	185 140	°C/W °C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	Standard Board	TSSOP-8	41 to 44	°C/W
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	DFN8 DFN8	129 84	°C/W
T <sub>sol</sub>	Wave Solder Pb Pb-Free			265 265	°C
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	(Note 2)	DFN8	35 to 40	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 4. PECL INPUT DC CHARACTERISTICS  $V_{CC} = 3.3 \text{ V}$ ; GND = 0.0 V (Note 3)

		-40°C		25°C		85°C					
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	2075		2420	2075		2420	2075		2420	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	1355		1675	1355		1675	1355		1675	mV
V <sub>BB</sub>	Output Voltage Reference	1775	1875	1975	1775	1875	1975	1775	1875	1975	V
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 4)	1.2		3.3	1.2		3.3	1.2		3.3	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current D D	-150 -150			-150 -150			-150 -150			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

<sup>2.</sup> JEDEC standard multilayer board - 2S2P (2 signal, 2 power)

<sup>3.</sup> Input parameters vary 1:1 with  $V_{CC}$ .

<sup>4.</sup> V<sub>IHCMR</sub> min varies 1:1 with GND, V<sub>IHCMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

Table 5. TTL OUTPUT DC CHARACTERISTICS  $V_{CC} = 3.3 \text{ V}$ ; GND = 0.0 V;  $T_A = -40 ^{\circ}\text{C}$  to  $85 ^{\circ}\text{C}$ 

Symbol	Characteristic	Condition	Min	Тур	Max	Unit
V <sub>OH</sub>	Output HIGH Voltage	I <sub>OH</sub> = -3.0 mA	2.4			V
V <sub>OL</sub>	Output LOW Voltage	I <sub>OL</sub> = 24 mA			0.5	V
I <sub>CCH</sub>	Power Supply Current		10	25	35	mA
I <sub>CCL</sub>	Power Supply Current		15	34	40	mA
Ios	Output Short Circuit Current		-50		-150	mA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

Table 6. AC CHARACTERISTICS  $V_{CC} = 3.0 \text{ V}$  to 3.6 V; GND = 0.0 V (Note 5)

		-40°C		25°C		85°C					
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f <sub>max</sub>	Maximum Frequency (Figure 2)	275	350		275	350		275	350		MHz
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay to Output Differential (Note 6)	1.2 1.2	1.5 1.5	2.0 1.8	1.2 1.2	1.5 1.5	2.0 1.8	1.3 1.2	1.7 1.5	2.2 1.8	ns
t <sub>SK++</sub> t <sub>SK</sub> t <sub>SKPP</sub>	Within Device Skew++ Within Device Skew Device-to-Device Skew (Note 7)		15 20 100	60 85 500		15 20 100	60 85 500		20 30 100	85 85 500	ps
t <sub>JITTER</sub>	Random Clock Jitter (RMS) (Figure 2) @ ≤ 200 MHz @ > 200 MHz		6 20	30 275		6 40	30 275		6 170	30 275	ps
V <sub>PP</sub>	Input Voltage Swing (Differential Configuration)	150	800	1200	150	800	1200	150	800	1200	mV
t <sub>r</sub> t <sub>f</sub>	Output Rise/Fall Times (0.8V $-$ 2.0V) Q, $\overline{\mathbb{Q}}$	330	600	950	330	600	950	330	650	950	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 5. Measured with a 750 mV 50% duty-cycle clock source.  $R_L$  = 500  $\Omega$  to GND and  $C_L$  = 20 pF to GND. Refer to Figure 3.
- 6. Reference ( $V_{CC}$  = 3.3 V  $\pm$  5%; GND = 0 V)
- 7. Skews are measured between outputs under identical transitions.

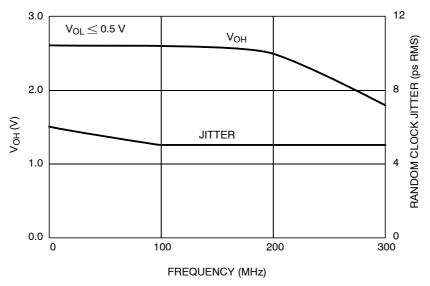


Figure 2. Typical V<sub>OH</sub> / Jitter versus Frequency (25°C)

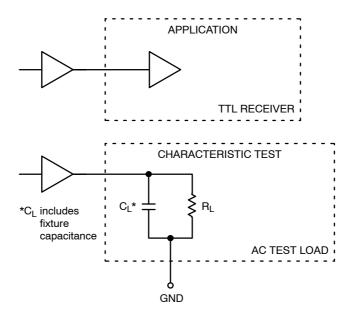


Figure 3. TTL Output Loading Used for Device Evaluation

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MC100EPT26D	SOIC-8	98 Units / Rail
MC100EPT26DG	SOIC-8 98 Units (Pb-Free)	
MC100EPT26DR2	SOIC-8	2500 / Tape & Reel
MC100EPT26DR2G	SOIC-8 (Pb-Free)	2500 / Tape & Reel
MC100EPT26DT	TSSOP-8	100 Units / Rail
MC100EPT26DTG	TSSOP-8 (Pb-Free)	100 Units / Rail
MC100EPT26DTR2	TSSOP-8	2500 / Tape & Reel
MC100EPT26DTR2G	TSSOP-8 (Pb-Free)	2500 / Tape & Reel
MC100EPT26MNR4	DFN8	1000 / Tape & Reel
MC100EPT26MNR4G	DFN8 (Pb-Free)	1000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **Resource Reference of Application Notes**

AN1405/D - ECL Clock Distribution Techniques

AN1406/D - Designing with PECL (ECL at +5.0 V)

AN1503/D - ECLinPS™ I/O SPiCE Modeling Kit

AN1504/D - Metastability and the ECLinPS Family

AN1568/D - Interfacing Between LVDS and ECL

AN1672/D - The ECL Translator Guide

AND8001/D - Odd Number Counters Design

AND8002/D - Marking and Date Codes

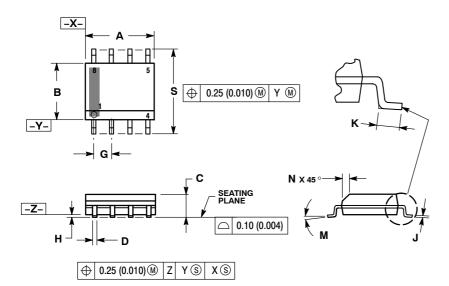
AND8020/D - Termination of ECL Logic Devices

AND8066/D - Interfacing with ECLinPS

AND8090/D - AC Characteristics of ECL Devices

#### PACKAGE DIMENSIONS

SOIC-8 NB CASE 751-07 **ISSUE AJ** 

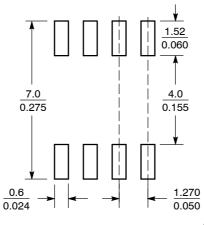


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- PER SIDE.

  DIMENSION D DOES NOT INCLUDE DAMBAR
  PROTRUSION. ALLOWABLE DAMBAR
  PROTRUSION SHALL BE 0.127 (0.005) TOTAL
  IN EXCESS OF THE D DIMENSION AT
  MAXIMUM MATERIAL CONDITION.
- 751–01 THRU 751–06 ARE OBSOLETE. NEW STANDARD IS 751–07.

	MILLIN	IETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27	7 BSC	0.050 BSC		
Н	0.10	0.25	0.004	0.010	
7	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
М	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

#### **SOLDERING FOOTPRINT\***

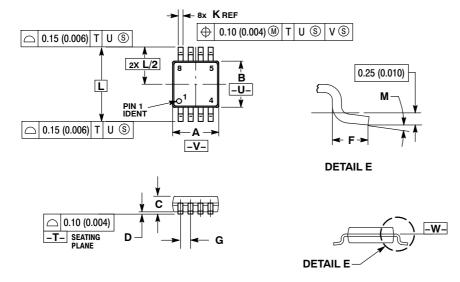


(mm inches) SCALE 6:1

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **PACKAGE DIMENSIONS**

#### TSSOP-8 **DT SUFFIX** PLASTIC TSSOP PACKAGE CASE 948R-02 **ISSUE A**



#### NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.

  4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.

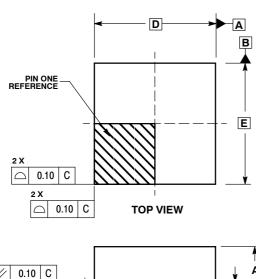
  5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.

  6. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE —W.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	2.90	3.10	0.114	0.122
В	2.90	3.10	0.114	0.122
С	0.80	1.10	0.031	0.043
D	0.05	0.15	0.002	0.006
F	0.40	0.70	0.016	0.028
G	0.65	BSC	0.026	BSC
K	0.25	0.40	0.010	0.016
L	4.90	BSC	0.193	BSC
М	0°	6 °	0°	6°

#### PACKAGE DIMENSIONS

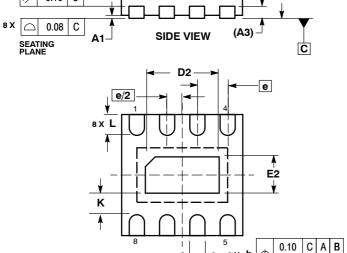
#### DFN8 CASE 506AA-01 ISSUE D



## NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994 .
- CONTROLLING DIMENSION: MILLIMETERS. DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN
- 0.25 AND 0.30 MM FROM TERMINAL. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.80	1.00			
A1	0.00	0.05			
A3	0.20 REF				
b	0.20	0.30			
D	2.00	BSC			
D2	1.10	1.30			
E	2.00	BSC			
E2	0.70	0.90			
е	0.50	BSC			
K	0.20				
L	0.25	0.35			



**BOTTOM VIEW** 

- 8 x b 0

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C NOTE 3

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